

<b>Notice of References Cited</b>	Application/Control No. 10/595,279	Applicant(s)/Patent Under Reexamination AKIHO ET AL.	
	Examiner Chuc D. Tran	Art Unit 2821	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,593,841	07-2003	Mizoguchi et al.	336/200
*	B	US-7,088,304	08-2006	Endo et al.	343/788
*	C	US-2007/0001921	01-2007	Takahashi et al.	343/788
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	I	US-			
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	K	US-			
	L	US-			
	M	US-			

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	N					
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**NON-PATENT DOCUMENTS**

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